

TOSHIBA HIGH EFFICIENCY DIODE STACK (HED) SILICON EPITAXIAL TYPE

# 30JL2C41

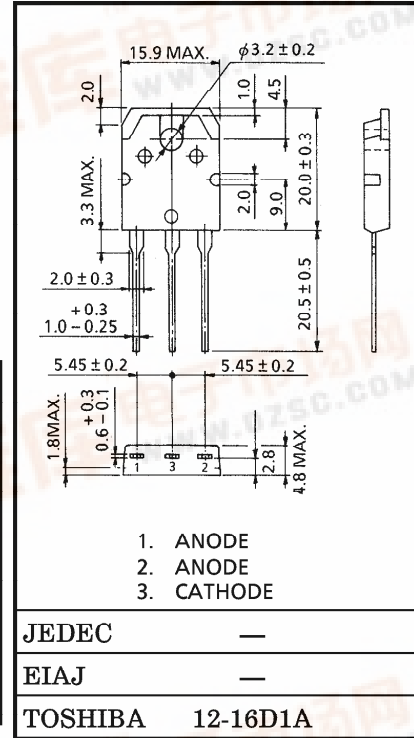
SWITCHING TYPE POWER SUPPLY APPLICATION  
CONVERTER & CHOPPER APPLICATION

Unit in mm

- Repetitive Peak Reverse Voltage :  $V_{RRM}=600V$
- Average Output Rectified Current :  $I_O=30A$
- Ultra Fast Reverse-Recovery Time :  $t_{rr}=50ns$  (Max.)
- Low Switching Losses and Output Noise.

MAXIMUM RATINGS

CHARACTERISTIC	SYMBOL	RATING	UNIT
Repetitive Peak Reverse Voltage	$V_{RRM}$	600	V
Average Output Rectified Current	$I_O$	30	A
Peak One Cycle Surge Forward Current (Sine Wave)	$I_{FSM}$	150 (50Hz) 165 (60Hz)	A
Junction Temperature	$T_j$	-40~150	°C
Storage Temperature Range	$T_{stg}$	-40~150	°C
Screw Torque	—	0.8	N·m



Weight : 4.85g

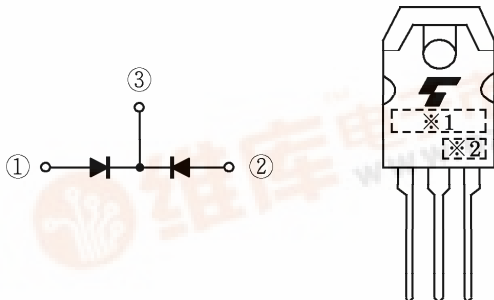
ELECTRICAL CHARACTERISTICS ( $T_a = 25^\circ C$ )

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	MAX.	UNIT
Peak Forward Voltage	$V_{FM}$	$I_{FM}=15A$	—	2.0	V
Repetitive Peak Reverse Current	$I_{RRM}$	$V_{RRM}=600V$	—	50	$\mu A$
Reverse Recovery time	$t_{rr}$	$I_F=2A, di/dt = -50A/\mu s$	—	50	ns
Forward Recovery time	$t_{fr}$	$I_F=1A$	—	150	ns
Thermal Resistance	$R_{th(j-c)}$	DC Total, Junction to Case	—	1.0	°C/W

$V_{FM}, I_{RRM}, t_{rr}, t_{fr}$  : A value of one cell.

POLARITY

MARKING



※1	MARK	30JL2C
※2	Lot Number	□□—Month (Starting from Alphabet A) └ Year (Last Number of the Christian Era)

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TOSHIBA is continually working to improve the quality and the reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to observe standards of safety, and to avoid situations in which a malfunction or failure of a TOSHIBA product could cause loss of human life, bodily injury or damage to property. In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent products specifications. Also, please keep in mind the precautions and conditions set forth in the TOSHIBA Semiconductor Reliability Handbook.

